



MJ P-Channel Enhancement Mode Power MOSFET

Description

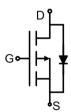
The MJ40P05Y uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

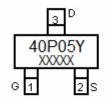
General Features

- Φ V_{DS} =-40V,I_D =-5.3A R_{DS(ON)} <85mΩ @ V_{GS} =-10V R_{DS(ON)} <125mΩ @ V_{GS} =-4.5V
- ♦ High density cell design for ultra low Rdson
- ◆ Fully characterized avalanche voltage and current
- ◆ Excellent package for good heat dissipation

Application

- ◆ Power switching application
- ◆ Hard switched and high frequency circuits
- ◆ DC-DC converter







Schematic diagram

Marking and pin assignment

SOT-23-3L top view

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
40P05Y	MJ40P05Y	SOT23-3L	Ø180mm	8 mm	3000 units

Absolute Maximum Ratings (Tc =25 ℃unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	VDS	-40	V
Gate-Source Voltage	VDS	±20	V
Drain Current-Continuous	ID (100℃)	-3.7	А
Pulsed Drain Current (Note 1)	IDM	-18	А
Maximum Power Dissipation	Po	2	W
Operating Junction and Storage Temperature Range	Тл,Тѕтс	-55 To 150	°C

Thermal Characteristic

Thermal Resistance, Junction-to-Ambient (Note 2)	RθJA	62.5	°C/W
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Electrical Characteristics (TA =25°Cunless otherwise noted)

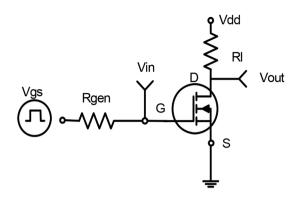
Parameter	Symbol	Condition	Min	Тур	Max	Uni
Off Characteristics	'	1				
Drain-Source Breakdown Voltage	BVpss	V _{GS} =0V I _D =250µA	-40	-	-	V
Zero Gate Voltage Drain Current	Ipss	V _{DS} =-40V,V _{GS} =0V	-	-	1	μA
Gate-Body Leakage Current	Igss	V _{DS} =±20V,V _{DS} =0V	_	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	VGS(th)	V _{DS} =V _{GS} ,I _D =250μA	-1.0	-1.9	-3.0	V
Orain-Source On-State Resistance	Rds(on)	V _{GS} =-10V, I _D =-5A	-	73	85	mΩ
Brain Godree On Grate Resistance	TADS(ON)	V _{GS} =-4.5V, I _D =-4A	-	98	125	mΩ
Forward Transconductance	g FS	V _{DS} =-5V,I _D =-3A	-	5	-	S
Dynamic Characteristics (Note 4)	'		ı			
Input Capacitance	Clss	V _{DS} =-20V,V _{GS} =0V, F=1.0MHz	-	600	-	PF
Output Capacitance	Coss		-	90	-	PF
Reverse Transfer Capacitance	Crss		-	70	-	PF
Switching Characteristics (Note 4)						
Turn-on Delay Time	t _{d(on)}		-	9	-	nS
Turn-on Rise Time	tr	V _{DD} =-20V, ,RL =2Ω	-	8	-	nS
Turn-Off Delay Time	t _{d(off)}	Vgs =-10V, Rgen =3 Ω	_	28	-	nS
Turn-Off Fall Time	tr	•	-	10	-	nS
Total Gate Charge	Qg	V _{DS} =-20V,I _D =-3A, V _{GS} =-10V	-	14	-	nC
Gate-Source Charge	Qgs		-	2.9	_	nC
Gate-Drain Charge	Q _{gd}	-	-	3.8	_	nC
Drain-Source Diode Characteristics	I	I	I	1	1	1
Diode Forward Voltage (Note 3)	VsD	V _{GS} =0V,I _S =-3.3A	-	_	1.2	V
Diode Forward Current (Note 2)	Is		_	-	-3.3	А

Notes:

- ① Repetitive Rating: Pulse width limited by maximum junction temperature.
- ② Surface Mounted on FR4 Board, $t \le 10$ sec.
- ③ Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
- 4 Guaranteed by design, not subject to production



Typical Electrical and Thermal Characteristics



 $t_{d(on)}$ $t_{d(off)}$ t_{d

Figure 1 Switching Test Circuit

Figure 2 Switching Waveforms

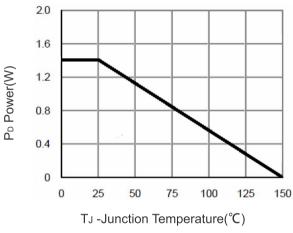
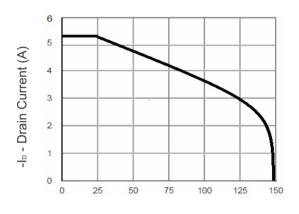
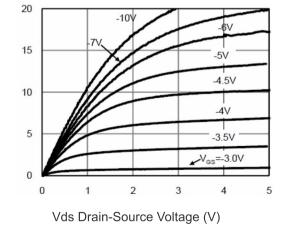


Figure 3 Power Dissipation



TJ -Junction Temperature(°C)
Figure 4 Drain Current



I_D - Drain Current (A)

Figure 5 Output Characteristics

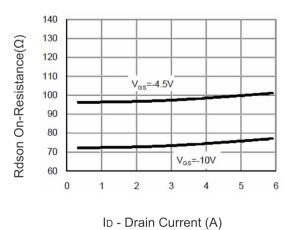


Figure 6 Drain-Source On-Resistance

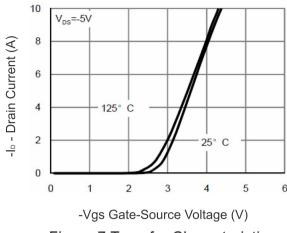


Figure 7 Transfer Characteristics

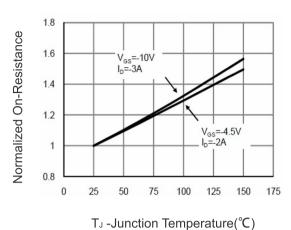


Figure 8 Drain-Source On-Resistance

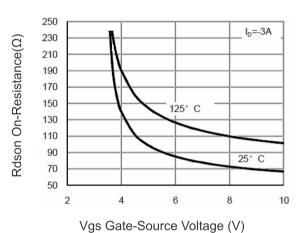
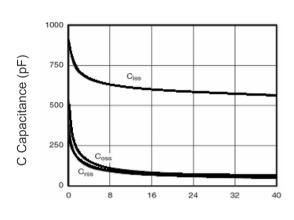


Figure 9 Rdson vs Vgs



Vds Drain-Source Voltage (V)
Figure 10 Capacitance vs Vds

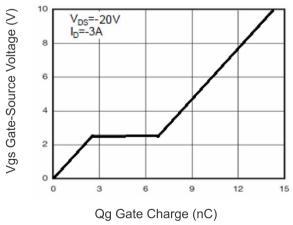


Figure 11 Gate Charge

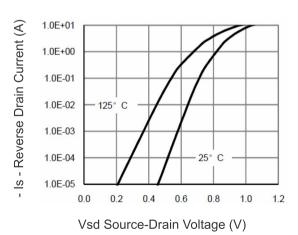


Figure 12 Source- Drain Diode Forward

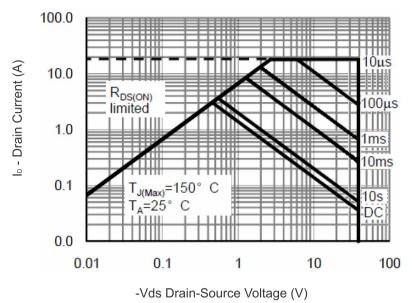
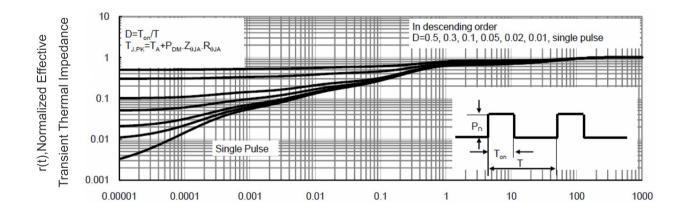


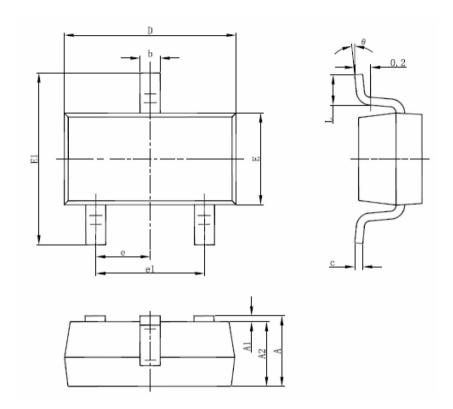
Figure 13 Safe Operation Area



Square Wave Pluse Duration(sec)
Figure 14 Normalized Maximum Transient Thermal Impedance



SOT-23-3L Package Information



Symbol	Dimensions Ir	Millimeters	Dimensions	In Inches	
Symbol	Min	Max	Min	Max	
Α	1.050	1.250	0.041	0.049	
A1	0.000	0.100	0.000	0.004	
A2	1.050	1.150	0.041	0.045	
b	0.300	0.500	0.012	0.020	
С	0.100	0.200	0.004	0.008	
D	2.820	3.020	0.111	0.119	
E	1.500	1.700	0.059	0.067	
E1	2.650	2.950	0.104	0.116	
е	0.950(BSC)		0.037(BSC)		
e1	1.800	2.000	0.071	0.079	
Ĺ	0.300	0.600	0.012	0.024	
θ	0°	8°	0°	8°	

Notes:

- ① All dimensions are in millimeters.
- ${f 2}$ Tolerance ${f \pm 0.10}$ mm (4 mil) unless otherwise specified
- 3 Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 5 mils.
- 4 Dimension L is measured in gauge plane.
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